

Joint Optimization of Fidelity And Commensurability for Manifold Alignment

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Dissimilarity Representation vs Feature Representation

j

i

			δ_{ij}		

$$\Delta = [\delta_{ij}]$$

$$\delta_{ij} \geq 0, \delta_{ii} = 0, \delta_{ij} = \delta_{ji}$$
$$i = \{1, \dots, n\} \quad j = \{1, \dots, n\}$$

i

	x_{im}		

$$x_i \in \mathbf{R}^d$$

How do we embed dissimilarities in Euclidean space?

Multidimensional Scaling [BorgGroenen1997]

Given $n \times n$ dissimilarity matrix

$\Delta = [\delta_{st}]; s = 1, \dots, n; t = 1, \dots, n,$

- Finds an embedding of the dissimilarities in the Euclidean space (with a chosen dimension d) such that the distances between the embeddings are as close as possible (in various senses) to the original dissimilarities in Δ .
- One function to measure closeness is the weighted raw-stress:

$$\sigma_W(X) = \sum_{1 \leq s \leq n; 1 \leq t \leq n} w_{st} (d_{st}(X) - \delta_{st})^2$$

where $d_{st}(X)$ is the Euclidean distance between s^{th} and t^{th} embedded points, and

weight matrix $W = [w_{st}]; s = 1, \dots, n; t = 1, \dots, n.$

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Problem Formulation for Dissimilarity Representation

Given K $n \times n$ dissimilarity matrices

$$\Delta^{(k)} = [\delta_{ij}]^{(k)}; 1 \leq i < j \leq n; k = 1, \dots, K;$$

- Dissimilarities between n objects are each measured under K different conditions.
- The set of dissimilarities under different conditions for the same object are “matched”.

Also given

$\mathbf{D}^{(k)} = \{\delta_i; i = 1, \dots, n\} \quad k = 1, \dots, K$: dissimilarities between K new measurements and previous n objects under the same K conditions.

Question we can answer

Do dissimilarities $\mathbf{D}^{(k)}$ come from K new measurements that represent a single object?

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Meaning of “conditions” and “matched”

	Condition 1	Condition 2
A linked collection of wikipedia articles	Textual content of an article	Hyperlink graph of articles
A linked collection of English and French wikipedia articles	The articles in English	The articles in French
Photos of same objects taken under different condition	Indoor photos	Outdoor photos

For $K=2$,

$$H_0 : \mathbf{D}^{(1)} \sim \mathbf{D}^{(2)} \text{ (Matched)}$$

versus

$$H_A : \mathbf{D}^{(1)} \not\sim \mathbf{D}^{(2)} \text{ (Not matched)}$$

(Hypothesis testing with α =constraint on the probability of missing a true match)

Omnibus Embedding Approach

$$\overset{2n \times 2n}{M} = \begin{bmatrix} \overset{n \times n}{\Delta_1} & \overset{n \times n}{L} \\ \overset{n \times n}{L}^T & \overset{n \times n}{\Delta_2} \end{bmatrix}$$

- Impute L (dissimilarities between different conditions) to obtain an *omnibus dissimilarity matrix* M
- Embed the omnibus matrix M as $2n$ points (one point for each condition of each object) in commensurate space (\mathbb{R}^d)

Out-of-sample Embedding

$$\begin{array}{ccc} \Delta & \longrightarrow & X \\ [D^{(k)}; k = 1, \dots, K] & \xrightarrow[X]{\text{OOS-embed}} & Y \end{array}$$

Omnibus Embedding Approach (OOS-embedding)

$$\begin{array}{c}
 {}^{2n \times 2n} \\
 M
 \end{array}
 =
 \begin{array}{c}
 \begin{array}{cc}
 \begin{array}{c} {}^{n \times n} \\ \Delta_1 \end{array} & \begin{array}{c} {}^{n \times n} \\ \textcolor{red}{L} \end{array} \\
 \begin{array}{c} \textcolor{red}{L}^T \\ \Delta_2 \end{array} & \begin{array}{c} {}^{n \times n} \\ \Delta_2 \end{array}
 \end{array}
 \begin{array}{cc}
 \begin{array}{c} {}^{n \times 1} \\ D^{(1)} \\ \vdots \end{array} & \begin{array}{c} {}^{n \times 1} \\ \vdots \end{array} \\
 \begin{array}{c} {}^{n \times 1} \\ \vdots \end{array} & \begin{array}{c} {}^{n \times 1} \\ D^{(2)} \end{array}
 \end{array}
 \end{array}
 \begin{array}{c}
 y_1 \\
 y_2
 \end{array}
 \begin{array}{c}
 D^{(1)T} \\
 D^{(2)T}
 \end{array}$$

General Approach

- 1 Map/Embed via MDS in-sample ($\Delta_k; k = 1, \dots, K$) dissimilarities into commensurate space.
- 2 Map/Embed (Out-of-sample) test dissimilarities ($\mathbf{D}^{(k)}; k = 1, \dots, K$) into commensurate space.
- 3 Compute test statistic τ (the distance between embeddings of test dissimilarities).
- 4 Reject null hypothesis if τ is large.

Fidelity and Commensurability Criteria

Fidelity is how well the mapping to commensurate space preserves original dissimilarities. Within-condition *fidelity error* is given by

$$\epsilon_{f_k} = \frac{1}{\binom{n}{2}} \sum_{1 \leq i < j \leq n} (d(\tilde{\mathbf{x}}_{ik}, \tilde{\mathbf{x}}_{jk}) - [\delta_{ij}]^{(k)})^2,$$

where $\tilde{\mathbf{x}}_{ik}$ is the embedded configuration of i th object for k th condition.

Fidelity and Commensurability Criteria

Commensurability is how well the mapping to commensurate space preserves matchedness. Between-condition *commensurability error* is given by

$$\epsilon_{c_{k_1 k_2}} = \frac{1}{n} \sum_{1 \leq i \leq n} (d(\tilde{\mathbf{x}}_{ik_1}, \tilde{\mathbf{x}}_{ik_2}) - [\delta_{ii}]^{(k_1, k_2)})^2$$

for different conditions k_1 and k_2 .

Although $[\delta_{ii}]^{(k_1, k_2)}$ is not available (the between-condition dissimilarities), it is not unreasonable in this setting to set $[\delta_{ii}]^{(k_1, k_2)} = 0$ for all i, k_1, k_2 . (We want embedded points of the same object to be close.)

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Commensurability and Fidelity Terms in Raw Stress

The weighted raw stress criterion for MDS with different conditions is

$$\sigma_W(X) = \sum_{i \leq j, k_1 \leq k_2} w_{ijk_1k_2} (d_{ijk_1k_2}(X) - [\delta_{ij}]^{(k_1, k_2)})^2$$

(i and j are the indices for the object, k_1 and k_2 are condition indices).

Ignoring some error terms (We can set $w_{ijk_1k_2} = 0$ for $i \neq j$ and $k_1 \neq k_2$)

$$\begin{aligned} \sigma_W(X) = & \underbrace{\sum_{i=j, k_1 < k_2} w_{ijk_1k_2} (d_{ijk_1k_2}(X) - [\delta_{ij}]^{(k_1, k_2)})^2}_{\text{Commensurability}} + \\ & \underbrace{\sum_{i < j, k_1 = k_2} w_{ijk_1k_2} (d_{ijk_1k_2}(X) - [\delta_{ij}]^{(k_1, k_2)})^2}_{\text{Fidelity}} \end{aligned}$$

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Which one is critical for hypothesis testing performance: Fidelity or Commensurability?

Setting $w_{ijk_1k_2}$ to $(1 - w)$ for Fidelity terms, and to w for Commensurability terms,

$$\sigma_w(X) = \underbrace{\sum_{i=j, k_1 < k_2} w (d_{ijk_1k_2}(X) - [\delta_{ij}]^{(k_1, k_2)})^2}_{\text{Commensurability}} + \underbrace{\sum_{i < j, k_1 = k_2} (1 - w) (d_{ijk_1k_2}(X) - [\delta_{ij}]^{(k_1, k_2)})^2}_{\text{Fidelity}}.$$

w controls the **tradeoff** between Fidelity and Commensurability.
Define w^* to be the value of w which maximizes power.

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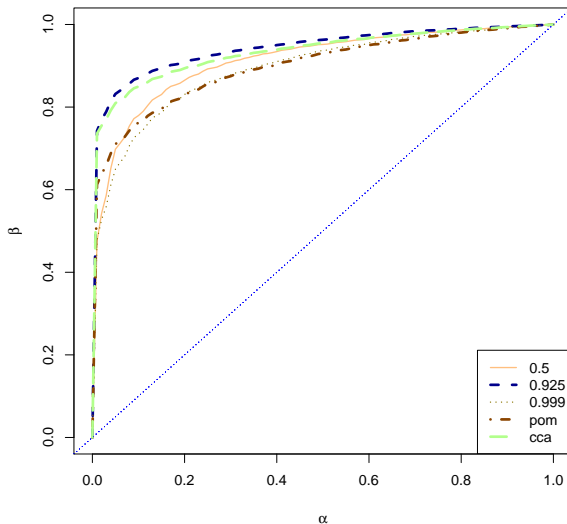
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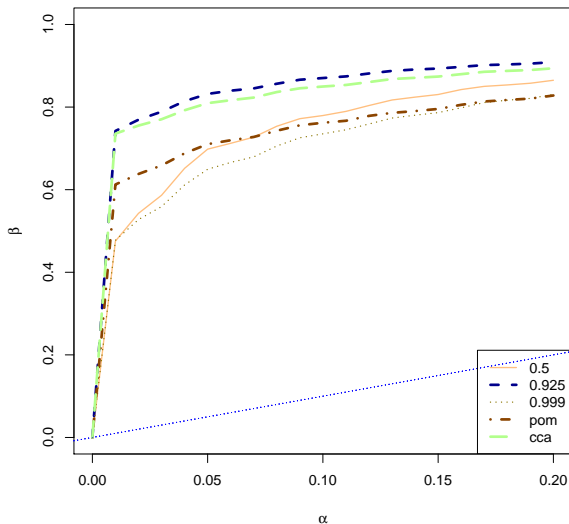
Simulation Results

ROC curves: Power(β) against allowable Type I error(α)



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Matching Dissimilarities

If multiple dissimilarities are available $\mathbf{D}_i^{(k)}, i = 1, \dots, n$ from two different conditions, what is the best matching of dissimilarities from two different conditions?

- Embed the dissimilarities
- Interpret the distances between embeddings as costs in an assignment problem
- Solve the linear assignment problem by the Hungarian algorithm:

Find the best assignment $f : \{1, \dots, s\} \rightarrow \{1, \dots, s\}$ that minimizes the cost

$$\sum_{i=1}^n C(i, f(i))$$

where the cost $C(\cdot, \cdot)$ is the distance between the embeddings of each dissimilarity from the different conditions.

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Vertex Correspondence: Graph matching with seeds

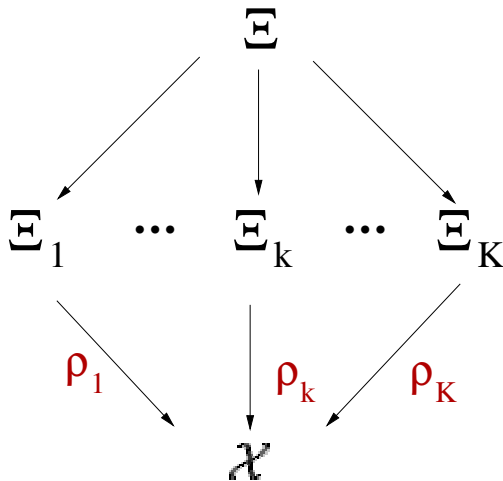
To solve the inexact graph matching problem with hard seeds where the objects we want to match are graph vertices,

- Compute dissimilarities between vertices
- Embed the hard seeds which are known to be matched with JOFC.
- OOS-embed the vertices to be matched.
- Compute dissimilarities between embeddings of vertices between different graphs
- Solve the linear assignment problem with dissimilarities as costs.

Conclusions and Future Work

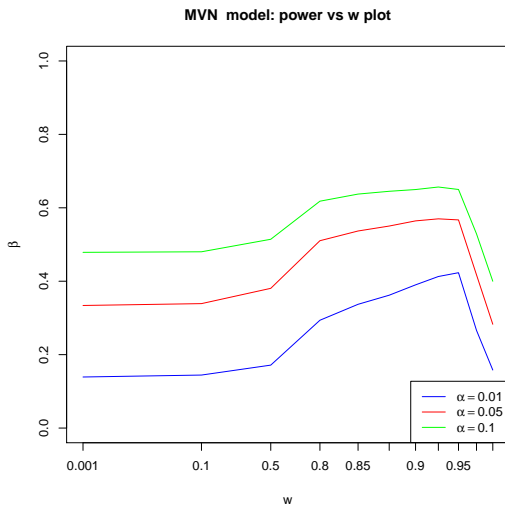
- Our JOFC approach is a general tool that can solve many kinds of related problems.
- The tradeoff between fidelity and commensurability , controlled by the parameter w has a big effect on the performance for the inference task.
- A particular type of graph matching problem can be solved using JOFC followed by the Hungarian algorithm.

Measurement Spaces and Commensurate Space



Simulation Results

Power(β) curves: Power(β) against w at fixed α





I. Borg and P. Groenen.

Modern Multidimensional Scaling. Theory and Applications.

Springer, 1997.



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